## PHB32N06LT



# N-channel TrenchMOS logic level FET Rev. 02 — 30 November 2009

**Product data sheet** 

## **Product profile**

## 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

#### 1.2 Features and benefits

Suitable for logic level gate drive sources

## 1.3 Applications

General purpose switching

Switched-mode power supplies

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	60	V
$I_D$	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 5 V; see <u>Figure 1</u> and <u>3</u>	-	-	34	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	97	W
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A};$ $V_{DS} = 44 \text{ V}; T_j = 25 \text{ °C};$ see Figure 11	-	8.5	-	nC
Static ch	aracteristics					
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C}$	-	31.5	43	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C};$ see Figure 9 and 10	-	30	40	mΩ



## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description		Simplified outline	Graphic symbol
1	G	gate			_
2	D	drain	[1]	mb	D D
3	S	source			
mb	D	mounting base; connected to drain			mbb076 S
				SOT404 (D2PAK)	

[1] It is not possible to make a connection to pin 2.

## 3. Ordering information

Table 3. Ordering information

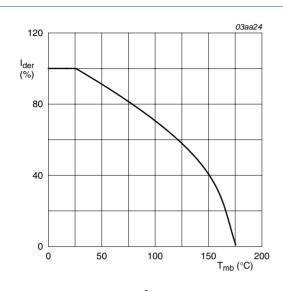
Type number	Package		
	Name	Description	Version
PHB32N06LT	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

## 4. Limiting values

Table 4. Limiting values

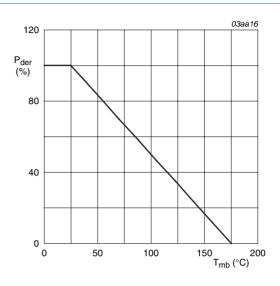
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 ^{\circ}\text{C}; T_j \le 175 ^{\circ}\text{C}$	-	60	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	60	٧
$V_{GS}$	gate-source voltage		-15	15	٧
I <sub>D</sub>	drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{Model}}$	-	24	Α
		$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{and } 3}$	-	34	Α
I <sub>DM</sub>	peak drain current	$t_p \le 10 \mu s$ ; pulsed; $T_{mb} = 25 \text{ °C}$ ; see Figure 3	-	136	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	97	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
$V_{GSM}$	peak gate-source voltage	pulsed; $t_p \le 50 \mu s$	-20	20	V
Source-dr	ain diode				
Is	source current	$T_{mb} = 25  ^{\circ}\text{C}$	-	34	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	136	Α
Avalanche	ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS} = 5$ V; $T_{j(init)} = 25$ °C; $I_D = 20$ A; $V_{sup} \le 25$ V; unclamped; $t_p = 0.11$ ms; $R_{GS} = 50$ $\Omega$	-	100	mJ



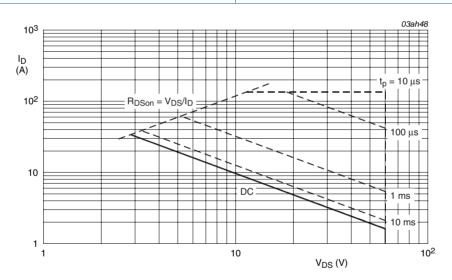
$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{amb} = 25$ °C;  $I_{DM}$  is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

## 5. Characteristics

Table 5. Characteristics

Table 5.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	55	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	60	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 8	-	-	2.3	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 8</u>	1	1.5	2	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 8	0.5	-	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
$I_{GSS}$	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 20 \text{ A}; T_j = 25 \text{ °C}$	-	31.5	43	mΩ
resistance	$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A}; T_j = 175 °C;$ see Figure 9 and 10	-	-	84	mΩ	
		$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A}; T_j = 25 \text{ °C}$	-	26	37	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A}; T_j = 25 \text{ °C};$ see Figure 9 and 10	-	30	40	mΩ
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 20 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	17	-	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 11</u>	-	3	-	nC
$Q_{GD}$	gate-drain charge		-	8.5	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	920	1280	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 12</u>	-	160	200	рF
$C_{rss}$	reverse transfer capacitance		-	100	155	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 5 \text{ V};$	-	14	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	120	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	45	-	ns
t <sub>f</sub>	fall time		-	55	-	ns
Source-di	rain diode					
$V_{SD}$	source-drain voltage	$I_S$ = 25 A; $V_{GS}$ = 0 V; $T_j$ = 25 °C; see <u>Figure 7</u>	-	1	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$	-	36	-	ns
Q <sub>r</sub>	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	70	-	nC

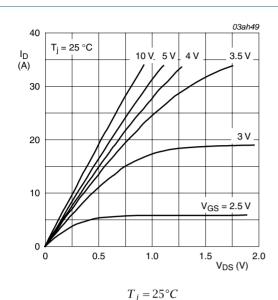
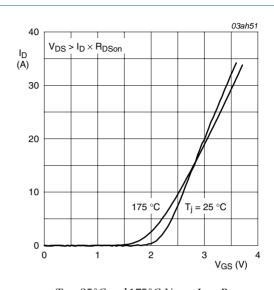


Fig 4. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25$ °C and 175°C; $V_{DS} > I_D \times R_{DSon}$ 



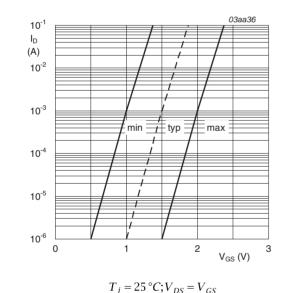


Fig 6. Sub-threshold drain current as a function of gate-source voltage

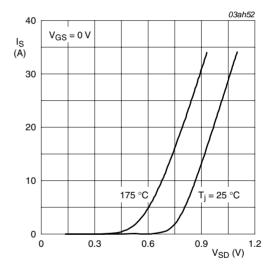
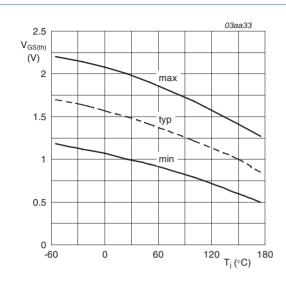


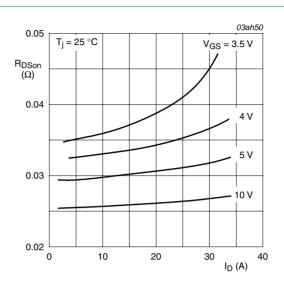
Fig 7. Source current as a function of source-drain voltage; typical values

 $T_i = 25^{\circ} C \text{ and } 175^{\circ} C; V_{GS} = 0V$ 



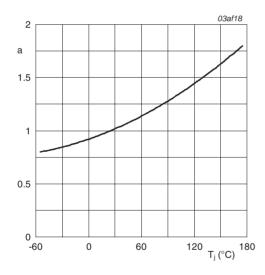
 $I_D = 1 \, mA; V_{DS} = V_{GS}$ 

Fig 8. Gate-source threshold voltage as a function of junction temperature



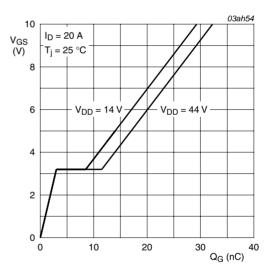
 $T_j = 25^{\circ}C$ 

Fig 9. Drain-source on-state resistance as a function of drain current; typical values



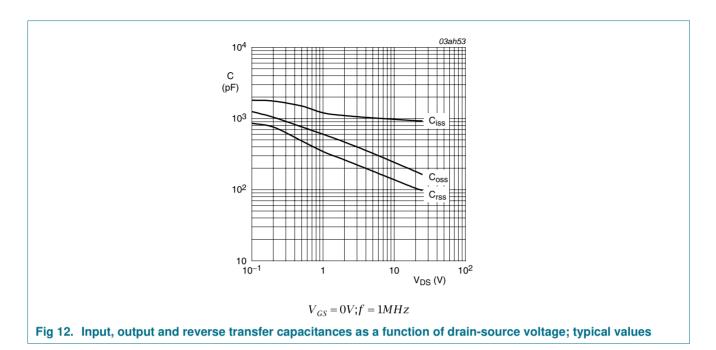
 $a = \frac{R_{DSon}}{R_{DSon(2.5^{\circ}C)}}$ 

Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature



$$T_j = 25^{\circ}C; I_D = 20A$$

Fig 11. Gate-source voltage as a function of turn-on gate charge; typical values



## 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see Figure 13	-	-	1.55	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	50	-	K/W

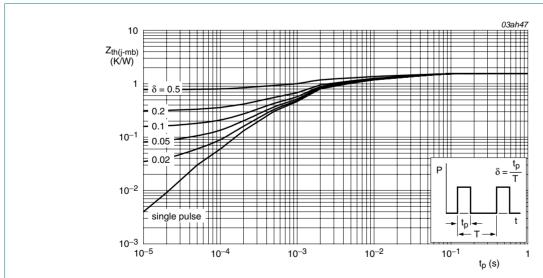
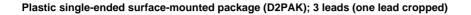
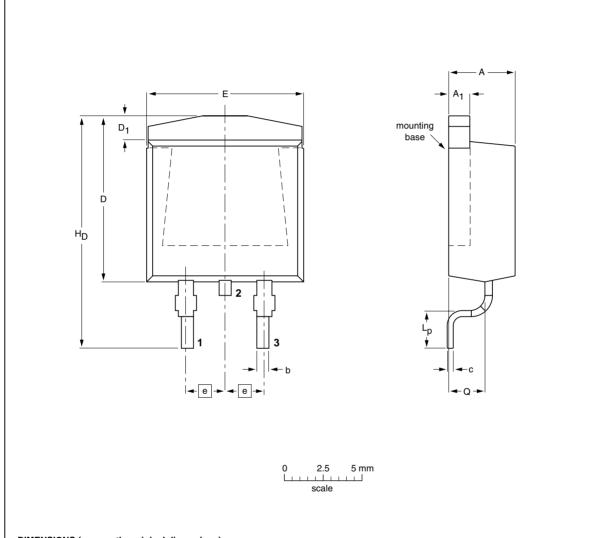


Fig 13. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 7. Package outline



**SOT404** 



DIMENS	ions (n	nm are t	he origii	nal dim	ensions)	

UNI	ГА	A <sub>1</sub>	b	С	D max.	D <sub>1</sub>	E	е	L <sub>p</sub>	Н <sub>D</sub>	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	2.54	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT404						<del>05-02-11</del> 06-03-16

Fig 14. Package outline SOT404 (D2PAK)

## 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHB32N06LT_2	20091130	Product data sheet	-	PHP_PHB_32N06LT-01
<ul> <li>Modifications:</li> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>				
PHP_PHB_32N06LT-01 (9397 750 09024)	20011106	Product data	-	-

## 9. Legal information

#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

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